

Enhancement Mode N-Channel Power MOSFET

 $TO-220F/NMOS/650V/\pm30V/3V/20A/0.38\Omega$

Rev_{0.6}





Enhancement Mode N-Channel Power MOSFET

1.Features

- Fast Switching
- ◆ Improved dv/dt Capability

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
650V	0.38Ω @ 10V	20A	

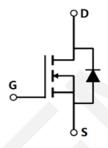
2.Applications

- ◆ Load Switch
- PWM Application
- Power management



Pin Description

TO-220F



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP20N65FA	WP20N65	TO-220F	50	5,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Value	Units
Drain to Source Voltage	$V_{ t DS}$	650	V
Gate to Source Voltage	V_{GS}	±30	V
Drain Current (DC)	I_D	20	А
Drain Current (Pulse), PW≤300μs	I _{DP}	80	А
Total Dissipation	P_{D}	120	W
Avalanche Energy, Single Pulsed	E _{AS}	1805	mJ
Junction Temperature	T_{j}	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	R _{eJC}	1.04	°C/W
Junction to ambient	$R_{ hetaJA}$	62.5	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

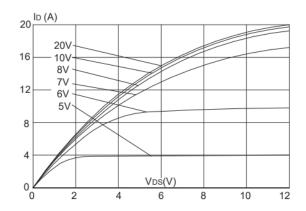
6.Electrical Characteristics at Ta=25°C (Note 3)

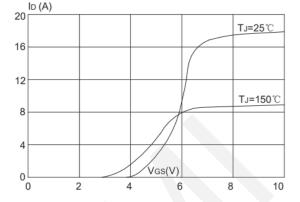
Parameter	Symbol	ymbol Test Conditions		Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	650			V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			1	μA
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±30V			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	2	3	4	V
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D = 10A, V _{GS} = 10V	-	0.38	0.42	Ω
Input Capacitance	C _{iss}	V _{GS} =0V,		3300		pF
Output Capacitance	C _{oss}	V _{DS} =25V,		255		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		13		pF
Turn-ON Delay Time	t _{d(on)}			37		ns
Rise Time	t _r	$V_{DD} = 325V, I_{D} = 20A,$		66		ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_G = 25\Omega$		175		ns
Fall Time	t _f			84		ns
	Q_g	V _{DD} = 520,		86		nC
Total Gate Charge	Q_{gs}	V _{GS} = 10V,		16		nC
	Q_{gd}	I _D = 20A		36		nC
Diode Forward Voltage	V_{FSD}	I _S =16A, V _{GS} = 0	0.55	0.85	1.1	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



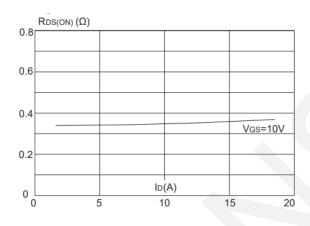
7. Typical electrical and thermal characteristics

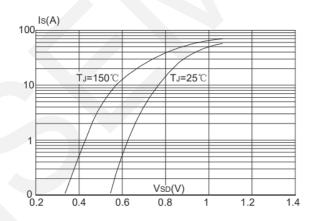




Output Characteristics

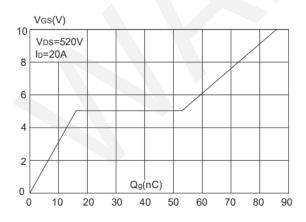
Typical Transfer Characteristics

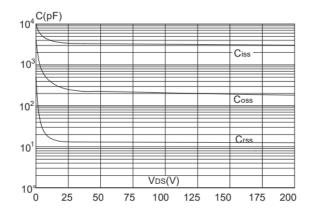




On-resistance vs. Drain Current

Body Diode Characteristics

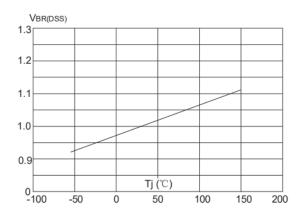




Gate Charge Characteristics

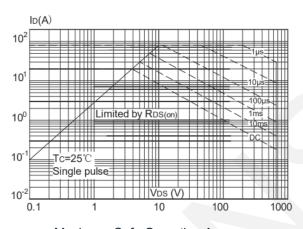
Capacitance Characteristics



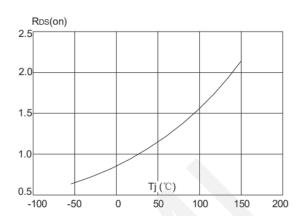


Normalized Breakdown Voltage vs.

Junction Temperature

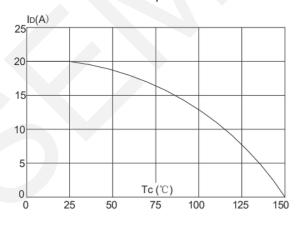


Maximum Safe Operating Area



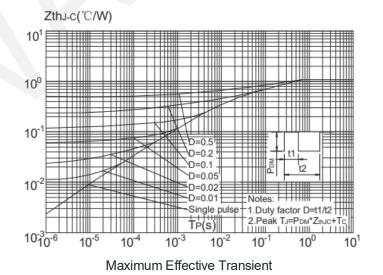
Normalized on Resistance vs.

Junction Temperature



Maximum Continuous Drain Current vs.

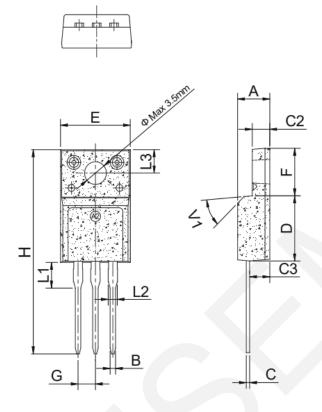
Case Temperature



Thermal Impedance, Junction-to-Case



8.Package Dimensions



		Dimensions				
Ref.		Millimete	rs			
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	4.50		4.90	0.177		0.193
В	0.74	0.80	0.83	0.029	0.031	0.033
С	0.47		0.65	0.019		0.026
C2	2.45		2.75	0.096		0.108
С3	2.60		3.00	0.102		0.118
D	8.80		9.30	0.346		0.366
E	9.80		10.4	0.386		0.410
F	6.40		6.80	0.252		0.268
G		2.54			0.1	
Н	28.0		29.8	1.102		1.173
L1		3.63			0.143	
L2	1.14		1.70	0.045		0.067
L3		3.30			0.130	
V1		45°			45°	



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